

STD30NF03L STD30NF03L-1

N-channel 30V - 0.020Ω - 30A - DPAK/IPAK STripFET™ II Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD30NF03L-1	30V	< 0.025Ω	30A
STD30NF03L	30V	< 0.025Ω	30A

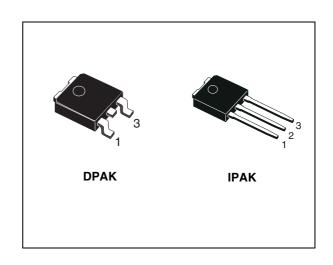
■ Low threshold drive

Description

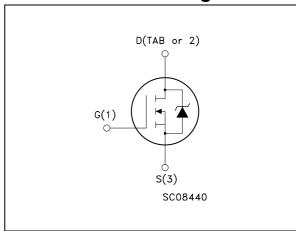
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature SizeTM" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD30NF03L-1	D30NF03L	IPAK	Tube
STD30NF03LT4	D30NF03L	DPAK	Tape & reel

February 2007 Rev 6 1/14

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value U		
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V	
V _{DGR}	Drain-gate voltage (R _{GS} = 20 kΩ)	30	V	
V _{GS}	Gate- source voltage	± 20	V	
I _D ⁽¹⁾	<u> </u>		Α	
I _D	Drain current (continuous) at T _C = 100°C	19	А	
I _{DM} ⁽²⁾	Drain current (pulsed)	120	Α	
P _{tot}	Total dissipation at T _C = 25°C	50		
	Derating Factor	0.27	W/°C	
E _{AS} (3)	Single pulse avalanche energy	100	mJ	
T _{stg}	Storage temperature		°C	
T _j	Max. operating junction temperature	-65 to 175		

- 1. Current limited by package
- 2. Pulse width limited by safe operating area.
- 3. Starting $T_i = 25$ °C, $I_D = 15A$ $V_{DD} = 15V$

Table 2. Thermal data

Rthj-pcb	Thermal resistance junction-pcb max	3.0	°C/W
Rthj-amb	Thermal resistance junction-ambient max	100	°C/W
Rthj-sink	Thermal resistance case-sink max	1.5	°C/W
TJ	Maximum lead temperature for soldering purpose	275	°C

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating, T_{C} = 125°C			1 10	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.7	2.5	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 15A$ $V_{GS} = 4.5V, I_D = 15A$		0.020 0.028	0.025 0.035	Ω Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} (1)	Forward transconductance	V _{DS} = 15V, I _D = 15A		13		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1MHz,$ $V_{GS} = 0$		830 230 92		pF pF pF
$\begin{array}{c} t_{\text{d(on)}} \\ t_{\text{r}} \\ t_{\text{d(off)}} \\ t_{\text{f}} \end{array}$	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 15V, I_D = 20A R_G = 4.7 Ω V_{GS} = 4.5V (see <i>Figure 12</i>)		35 205 90 240		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 24V, I_D = 30A, V_{GS} = 5V, R_G = 4.7 Ω (see <i>Figure 13</i>)		18 7 8		nC nC nC

^{1.} Pulsed: Pulse duration = 300 μs, duty cycle 1.5%.

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Table 5. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				30 240	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 30A, V _{GS} = 0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 40A, di/dt = 100A/µs, V_{DD} = 15V, T_j = 150°C (see <i>Figure 14</i>)		65 72 2		ns nC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

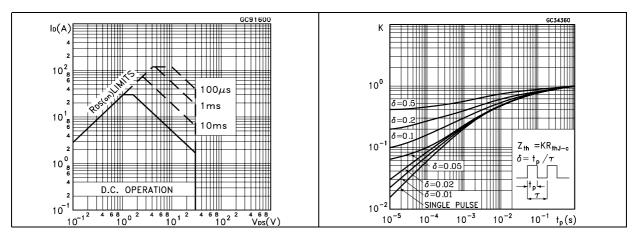


Figure 3. Output characteristics

Figure 4. Transfer characteristics

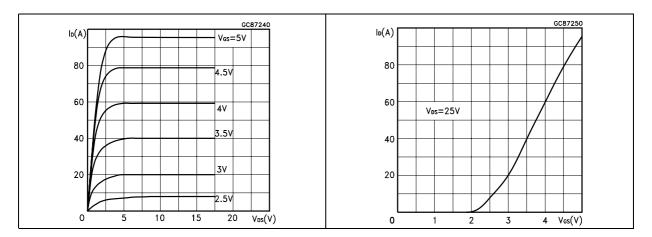


Figure 5. Transconductance

Figure 6. Static drain-source on resistance

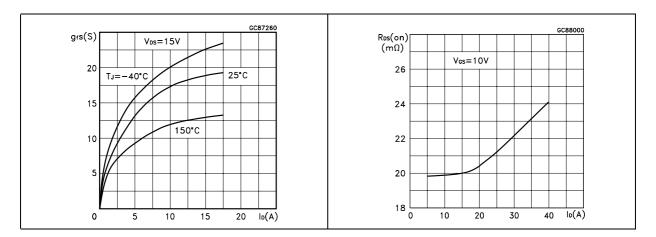


Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations

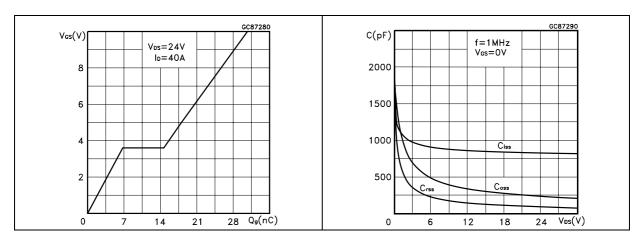


Figure 9. Normalized gate threshold voltage vs. temperature

Figure 10. Normalized on resistance vs. temperature

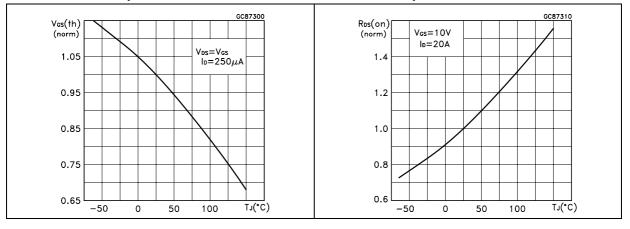
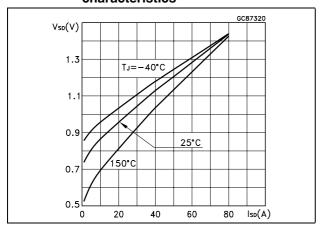


Figure 11. Source-drain diode forward characteristics



Test circuit 3

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

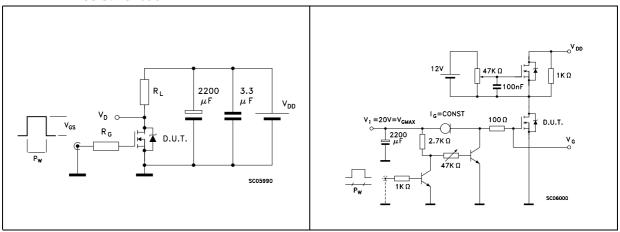


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped Inductive load test circuit

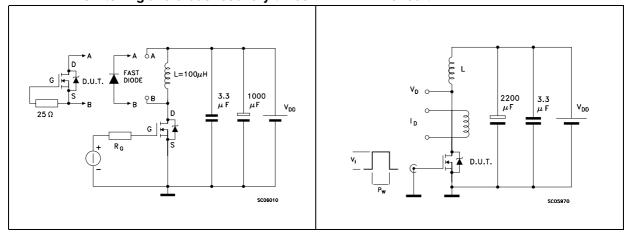
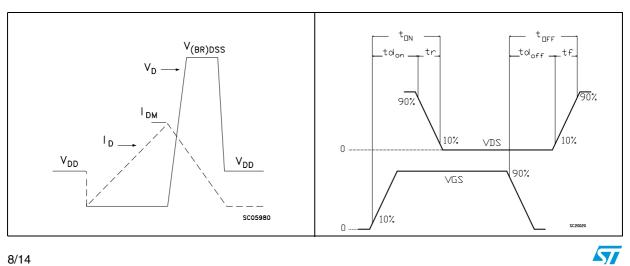


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform

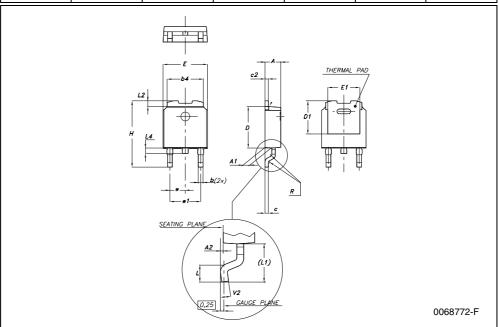


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

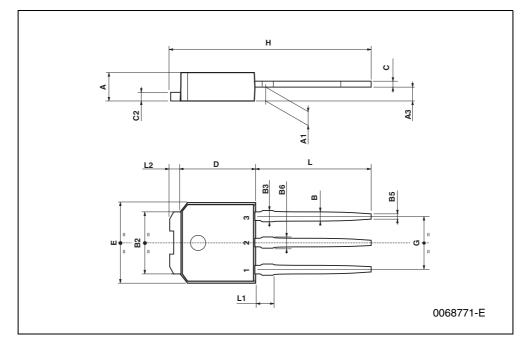
DPAK MECHANICAL DATA

DIM.		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°



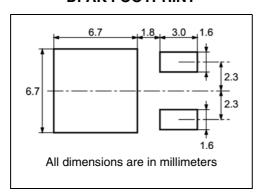
TO-251 (IPAK) MECHANICAL DATA	TO-251	(IPAK)	MECHANICAL	DATA
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DIM.		mm			inch	
DIW.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
В6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039

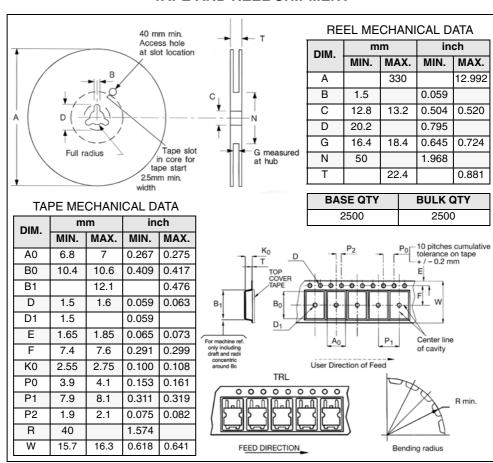


5 Packing mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



6 Revision history

Table 6. Revision history

Date	Revision	Changes
21-Jun-2004	4	Preliminary version
03-Jul-2006	5	New template, no content change
20-Feb-2007	6	Typo mistake on page 1

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